

Application/Control No.	Applicant(s)/Patent under Reexamination
09/708,263	OGISHI ET AL.
Examiner	Art Unit
David Y. Jung	2134

	SEAR	CHED	
Class	Subclass	Date	Examiner
380	44	2/18/2007	DJ
380	46	2/18/2007	. DJ
380	28	2/18/2007	DJ
			-
,			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
380	44	2/18/2007	רם		
380	46	2/18/2007	DJ		
380	28	2/18/2007	DJ		

SEARCH N (INCLUDING SEAR)
	DATE	EXMR
look at previously searched subclasses of US Patents	2/18/2007	DJ
West, NPL, Internet	2/18/2007	DJ